


<b>Search Notes</b> 	<b>Application/Control No.</b> 10509074	<b>Applicant(s)/Patent Under Reexamination</b> CHEN ET AL.
	<b>Examiner</b> Sabiha Qazi	<b>Art Unit</b> 1612

SEARCHED			
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SEARCH NOTES		
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STN DATABASE SEARCH, REGISTRY, AUTHOR SEARCH, CAPLUS, MARPAT, WPIX	1/26/10	STIC

INTERFERENCE SEARCH			
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	/Sabiha Qazi/ Primary Examiner.Art Unit 1612
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